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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	547
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	69
Number of Gates	2000
Voltage - Supply	4.5V ~ 5.5V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	84-CQFP Exposed Pad and Tie Bar
Supplier Device Package	84-CQFP (42x42)
Purchase URL	https://www.e-xfl.com/product-detail/microsemi/a1020b-1cq84c

DESC SMD/Actel Part Number Cross Reference

Actel Part Number (Gold Leads)	DSCC SMD (Gold Leads)	DSCC SMD (Solder Dipped)
A1010B-PG84B	5962-9096403MXC	5962-9096403MXA
A1010B-1PG84B	5962-9096404MXC	5962-9096404MXA
A1020B-PG84B	5962-9096503MUC	5962-9096503MUA
A1020B-1PG84B	5962-9096504MUC	5962-9096504MUA
A1020B-CQ84B	5962-9096503MTC	5962-9096503MTA
A1020B-1CQ84B	5962-9096504MTC	5962-9096504MTA
A1240A-PG132B	5962-9322101MXC	5962-9322101MXA
A1240A-1PG132B	5962-9322102MXC	5962-9322102MXA
A1280A-PG176B	5962-9215601MXC	5962-9215601MXA
A1280A-1PG176B	5962-9215602MXC	5962-9215602MXA
A1280A-CQ172B	5962-9215601MYC	5962-9215601MYA
A1280A-1CQ172B	5962-9215602MYC	5962-9215602MYA
A1425A-PG133B	5962-9552001MXC	N/A
A1425A-1PG133B	5962-9552002MXC	N/A
A1425A-CQ132B	5962-9552001MYC	N/A
A1425A-1CQ132B	5962-9552002MYC	N/A
A1460A-PG207B	5962-9550801MXC	N/A
A1460A-1PG207B	5962-9550802MXC	N/A
A1460A-CQ196B	5962-9550801MYC	N/A
A1460A-1CQ196B	5962-9550802MYC	N/A
A14100A-PG257B	5962-9552101MXC	N/A
A14100A-1PG257B	5962-9552102MXC	N/A
A14100A-CQ256B	5962-9552101MYC	N/A
A14100A-1CQ256B	5962-9552102MYC	N/A
A32100DX-CQ84B	5962-9875901QXC	N/A
A32100DX-1CQ84B	5962-9857902QXC	N/A
A32200DX-CQ256B	5962-9952701QXC	N/A
A32200DX-1CQ256B	5962-9952702QXC	N/A
A32200DX-CQ208B	5962-9952701QYC	N/A
A32200DX-1CQ208B	5962-9952702QYC	N/A

Product Plan

	Speed Grade		Application			
3200DX Family	**Std**	**–1***	**C**	**M**	**B**	**E**
A32100DX Device						
84-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	—
A32200DX Device						
208-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	—
256-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	—
ACT 3 Family						
A1425A Device						
132-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	✔
133-pin Ceramic Pin Grid Array (CPGA)	✔	✔	✔	✔	✔	✔
A1460A Device						
196-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	✔
207-pin Ceramic Pin Grid Array (CPGA)	✔	✔	✔	✔	✔	✔
A14100A Device						
256-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	✔
257-pin Ceramic Pin Grid Array (CPGA)	✔	✔	✔	✔	✔	✔
1200XL Family						
A1280XL Device						
172-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	—
176-pin Ceramic Pin Grid Array (CPGA)	✔	✔	✔	✔	✔	—
ACT 2 Family						
A1240A Device						
132-pin Ceramic Pin Grid Array (CPGA)	✔	✔	✔	✔	✔	—
A1280A Device						
172-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	✔
176-pin Ceramic Pin Grid Array (CPGA)	✔	✔	✔	✔	✔	✔
ACT 1 Family						
A1010B Device						
84-pin Ceramic Pin Grid Array (CPGA)	✔	✔	✔	✔	✔	—
A1020B Device						
84-pin Ceramic Quad Flat Pack (CQFP)	✔	✔	✔	✔	✔	✔
84-pin Ceramic Pin Grid Array (CPGA)	✔	✔	✔	✔	✔	✔

Applications: *C = Commercial* *M = Military* *B = MIL-STD-883* *E = Extended Flow*

Availability: ✔ = *Available* — = *Not Planned*

**Speed Grade:* *–1 = Approx. 15% faster than Standard*

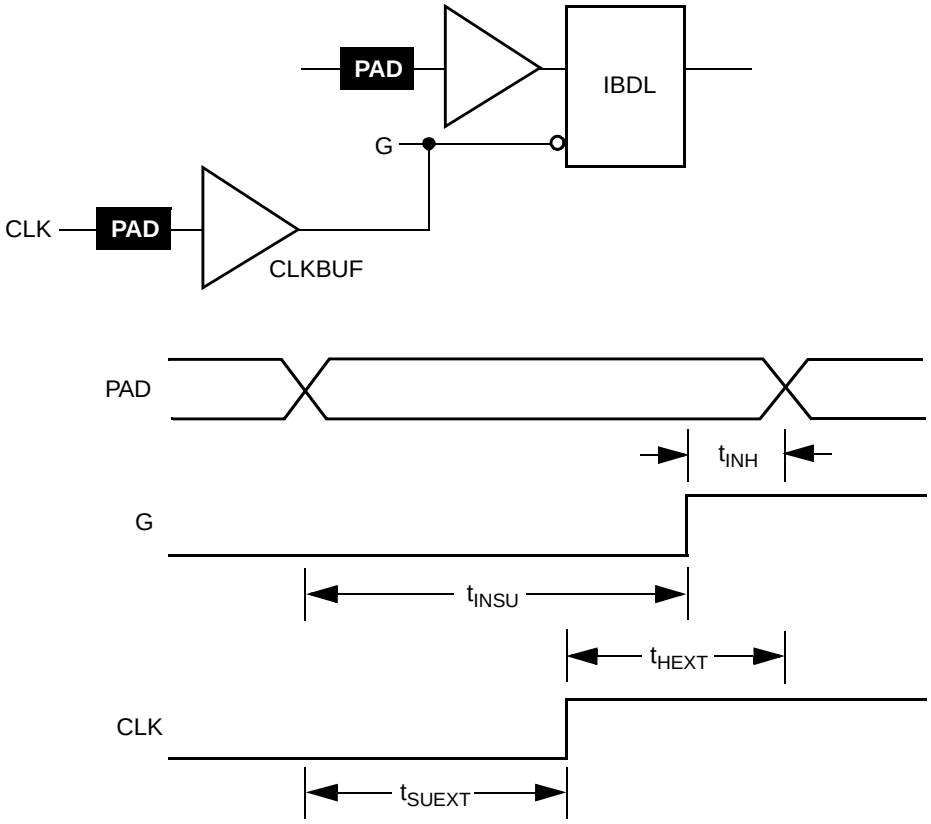
Actel MIL-STD-883 Product Flow

Step	Screen	883 Method	883—Class B Requirement
1.	Internal Visual	2010, Test Condition B	100%
2.	Temperature Cycling	1010, Test Condition C	100%
3.	Constant Acceleration	2001, Test Condition D or E, Y_1, Orientation Only	100%
4.	Seal	1014	
	a. Fine		100%
	b. Gross		100%
5.	Visual Inspection	2009	100%
6.	Pre-Burn-In Electrical Parameters	In accordance with applicable Actel device specification	100%
7.	Burn-in Test	1015, Condition D, 160 hours @ 125°C or 80 hours @ 150°C	100%
8.	Interim (Post-Burn-In) Electrical Parameters	In accordance with applicable Actel device specification	100%
9.	Percent Defective Allowable	5%	All Lots
10.	Final Electrical Test	In accordance with applicable Actel device specification, which includes a, b, and c:	
	a. Static Tests		100%
	(1) 25°C (Subgroup 1, Table I)	5005	
	(2) –55°C and +125°C (Subgroups 2, 3, Table I)	5005	
	b. Functional Tests		100%
	(1) 25°C (Subgroup 7, Table I)	5005	
	(2) –55°C and +125°C (Subgroups 8A and 8B, Table I)	5005	
	c. Switching Tests at 25°C (Subgroup 9, Table I)	5005	100%
11.	External Visual	2009	100%

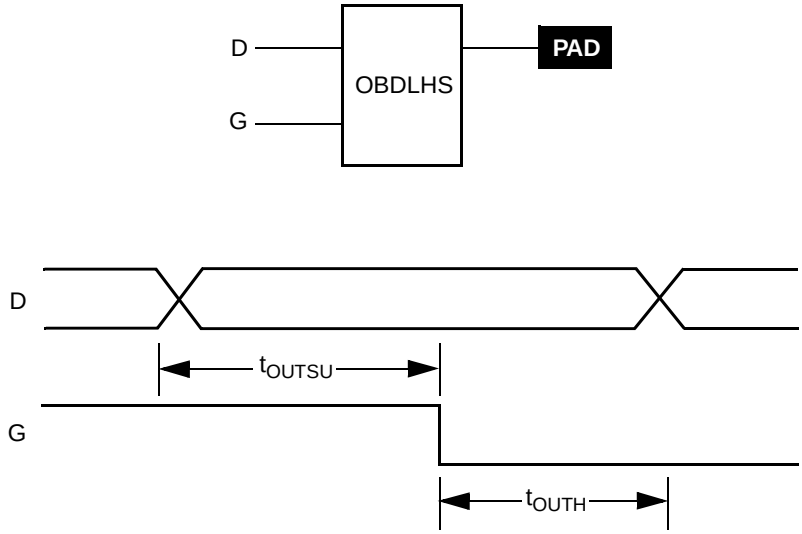
Note: *When Destructive Physical Analysis (DPA) is performed on Class B devices, the step coverage requirement as specified in Method 2018 must be waived.*

Sequential Timing Characteristics (continued)

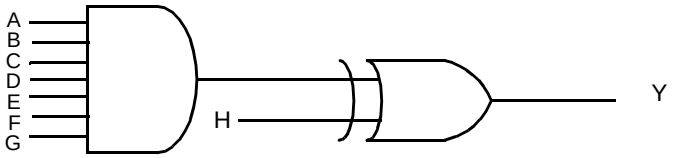
Input Buffer Latches (ACT 2 and 1200XL/3200DX)

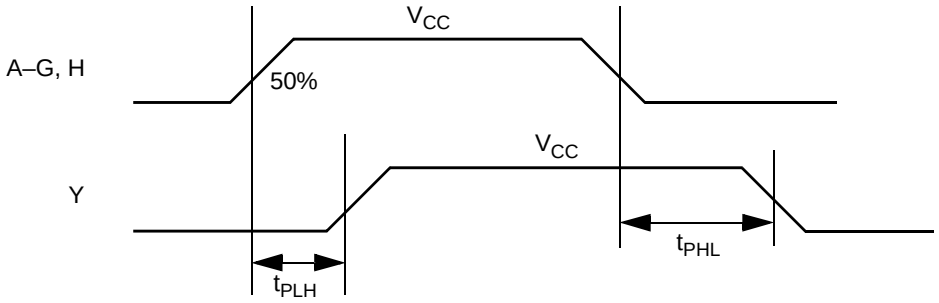


Output Buffer Latches (ACT 2 and 1200XL/3200DX)

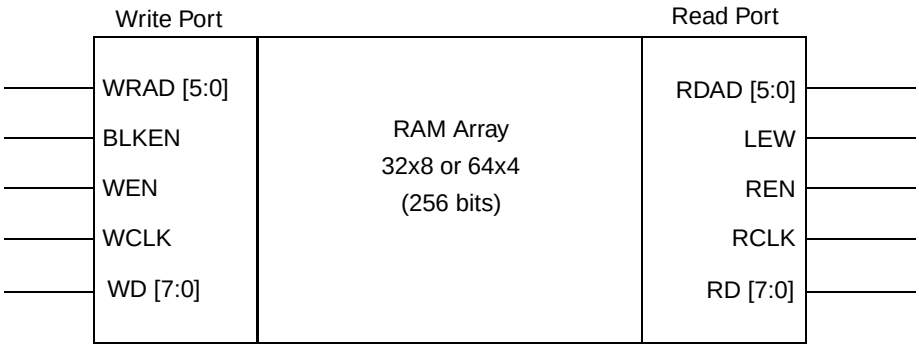


Decode Module Timing



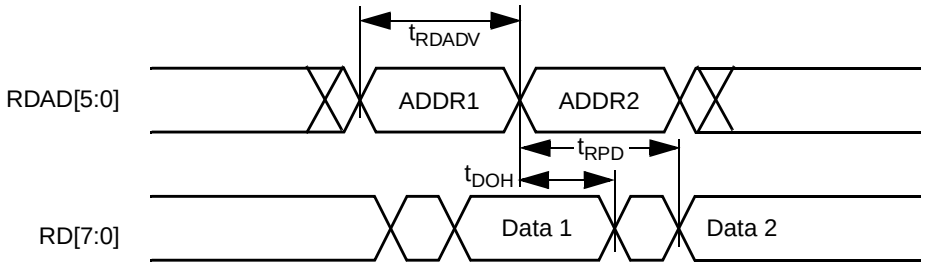


SRAM Timing Characteristics



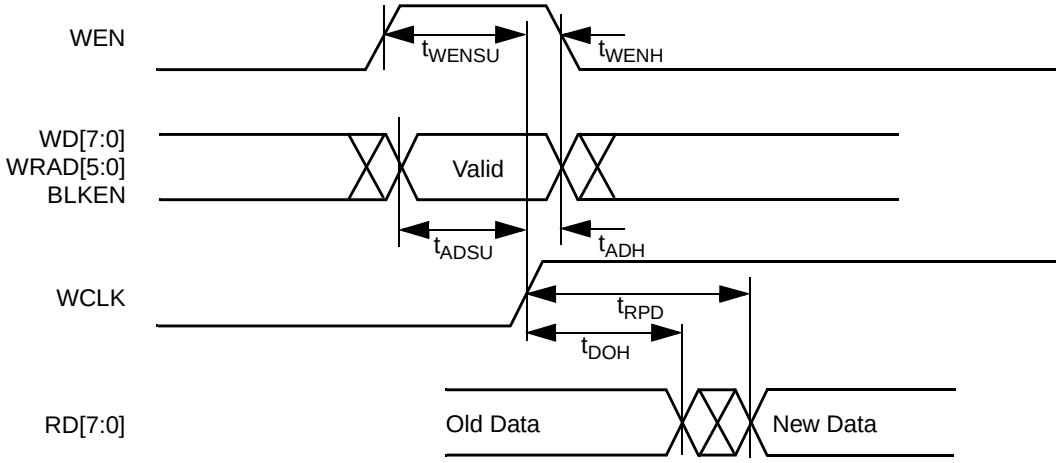
3200DX SRAM Asynchronous Read Operation—Type 1

(Read Address Controlled)



3200DX SRAM Asynchronous Read Operation—Type 2

(Write Address Controlled)



ACT 1 Timing Characteristics

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

		'–1' Speed		'Std' Speed		
Parameter	**Description**	**Min.**	**Max.**	**Min.**	**Max.**	**Units**
Logic Module Propagation Delays						
t_{PD1}	Single Module		4.7		5.5	ns
t_{PD2}	Dual Module Macros		10.8		12.7	ns
t_{CO}	Sequential Clk to Q		4.7		5.5	ns
t_{GO}	Latch G to Q		4.7		5.5	ns
t_{RS}	Flip-Flop (Latch) Reset to Q		4.7		5.5	ns
Logic Module Predicted Routing Delays[1]						
t_{RD1}	FO=1 Routing Delay		1.5		1.7	ns
t_{RD2}	FO=2 Routing Delay		2.3		2.7	ns
t_{RD3}	FO=3 Routing Delay		3.4		4.0	ns
t_{RD4}	FO=4 Routing Delay		5.0		5.9	ns
t_{RD8}	FO=8 Routing Delay		10.6		12.5	ns
Logic Module Sequential Timing [2]						
t_{SUD}	Flip-Flop (Latch) Data Input Setup	8.8		10.4		ns
t_{HD}	Flip-Flop (Latch) Data Input Hold	0.0		0.0		ns
t_{SUENA}	Flip-Flop (Latch) Enable Setup	8.8		10.4		ns
t_{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		ns
t_{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	10.9		12.9		ns
t_{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	10.9		12.9		ns
t_A	Flip-Flop Clock Input Period	23.2		27.3		ns
f_{MAX}	Flip-Flop (Latch) Clock Frequency		44		37	MHz
Input Module Propagation Delays						
t_{INYH}	Pad to Y High		4.9		5.8	ns
t_{INYL}	Pad to Y Low		4.9		5.8	ns
Input Module Predicted Routing Delays[1, 3]						
t_{IRD1}	FO=1 Routing Delay		1.5		1.7	ns
t_{IRD2}	FO=2 Routing Delay		2.3		2.7	ns
t_{IRD3}	FO=3 Routing Delay		3.4		4.0	ns
t_{IRD4}	FO=4 Routing Delay		5.0		5.9	ns
t_{IRD8}	FO=8 Routing Delay		10.6		12.5	ns

Notes:

1. *Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.*
2. *Setup times assume fanout of 3. Further derating information can be obtained from the DirectTime Analyzer utility.*
3. *Optimization techniques may further reduce delays by 0 to 4 ns.*

A1240A Timing Characteristics (continued)

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

		'–1' Speed		'Std' Speed		
Parameter	**Description**	**Min.**	**Max.**	**Min.**	**Max.**	**Units**
TTL Output Module Timing[1]						
t_{DLH}	Data to Pad High		11.0		13.0	ns
t_{DHL}	Data to Pad Low		13.9		16.4	ns
t_{ENZH}	Enable Pad Z to High		12.3		14.4	ns
t_{ENZL}	Enable Pad Z to Low		16.1		19.0	ns
t_{ENHZ}	Enable Pad High to Z		9.8		11.5	ns
t_{ENLZ}	Enable Pad Low to Z		11.5		13.6	ns
t_{GLH}	G to Pad High		12.4		14.6	ns
t_{GHL}	G to Pad Low		15.5		18.2	ns
d_{TLH}	Delta Low to High		0.09		0.11	ns/pF
d_{THL}	Delta High to Low		0.17		0.20	ns/pF
CMOS Output Module Timing[1]						
t_{DLH}	Data to Pad High		14.0		16.5	ns
t_{DHL}	Data to Pad Low		11.7		13.7	ns
t_{ENZH}	Enable Pad Z to High		12.3		14.4	ns
t_{ENZL}	Enable Pad Z to Low		16.1		19.0	ns
t_{ENHZ}	Enable Pad High to Z		9.8		11.5	ns
t_{ENLZ}	Enable Pad Low to Z		11.5		13.6	ns
t_{GLH}	G to Pad High		12.4		14.6	ns
t_{GHL}	G to Pad Low		15.5		18.2	ns
d_{TLH}	Delta Low to High		0.17		0.20	ns/pF
d_{THL}	Delta High to Low		0.12		0.15	ns/pF

Notes:

1. *Delays based on 50 pF loading.*
2. *SSO information can be found in the* Simultaneously Switching Output Limits for Actel FPGAs *application note at http://www.actel.com/appnotes.*

A1280A Timing Characteristics (continued)

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

			'–1' Speed		'Std' Speed		
Parameter	**Description**		**Min.**	**Max.**	**Min.**	**Max.**	**Units**
Input Module Propagation Delays							
t_{INYH}	Pad to Y High			4.0		4.7	ns
t_{INYL}	Pad to Y Low			3.6		4.3	ns
t_{INGH}	G to Y High			6.9		8.1	ns
t_{INGL}	G to Y Low			6.6		7.7	ns
Input Module Predicted Routing Delays[1]							
t_{RD1}	FO=1 Routing Delay			6.2		7.3	ns
t_{RD2}	FO=2 Routing Delay			7.2		8.4	ns
t_{RD3}	FO=3 Routing Delay			7.7		9.1	ns
t_{RD4}	FO=4 Routing Delay			8.9		10.5	ns
t_{RD8}	FO=8 Routing Delay			12.9		15.2	ns
Global Clock Network							
t_{CKH}	Input Low to High	FO = 32 FO = 384		13.3 17.9		15.7 21.1	ns
t_{CKL}	Input High to Low	FO = 32 FO = 384		13.3 18.2		15.7 21.4	ns
t_{PWH}	Minimum Pulse Width High	FO = 32 FO = 384	6.9 7.9		8.1 9.3		ns
t_{PWL}	Minimum Pulse Width Low	FO = 32 FO = 384	6.9 7.9		8.1 9.3		ns
t_{CKSW}	Maximum Skew	FO = 32 FO = 384		0.6 3.1		0.6 3.1	ns
t_{SUEXT}	Input Latch External Setup	FO = 32 FO = 384	0.0 0.0		0.0 0.0		ns
t_{HEXT}	Input Latch External Hold	FO = 32 FO = 384	8.6 13.8		8.6 13.8		ns
t_P	Minimum Period	FO = 32 FO = 384	13.7 16.0		16.2 18.9		ns
f_{MAX}	Maximum Frequency	FO = 32 FO = 384		73 63		62 53	MHz

Note:

1. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment. Optimization techniques may further reduce delays by 0 to 4 ns.

A1460A Timing Characteristics

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

		'–1' Speed		'Std' Speed		
Parameter	**Description**	**Min.**	**Max.**	**Min.**	**Max.**	**Units**
Logic Module Propagation Delays[1]						
t_{PD}	Internal Array Module		3.0		3.5	ns
t_{CO}	Sequential Clock to Q		3.0		3.5	ns
t_{CLR}	Asynchronous Clear to Q		3.0		3.5	ns
Logic Module Predicted Routing Delays[2]						
t_{RD1}	FO=1 Routing Delay		1.3		1.5	ns
t_{RD2}	FO=2 Routing Delay		1.9		2.1	ns
t_{RD3}	FO=3 Routing Delay		2.1		2.5	ns
t_{RD4}	FO=4 Routing Delay		2.6		2.9	ns
t_{RD8}	FO=8 Routing Delay		4.2		4.9	ns
Logic Module Sequential Timing						
t_{SUD}	Flip-Flop (Latch) Data Input Setup	0.9		1.0		ns
t_{HD}	Flip-Flop (Latch) Data Input Hold	0.0		0.0		ns
t_{SUENA}	Flip-Flop (Latch) Enable Setup	0.9		1.0		ns
t_{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		ns
t_{WASYN}	Asynchronous Pulse Width	4.8		5.6		ns
t_{WCLKA}	Flip-Flop Clock Pulse Width	4.8		5.6		ns
t_{A}	Flip-Flop Clock Input Period	9.9		11.6		ns
f_{MAX}	Flip-Flop Clock Frequency		100		85	MHz
Input Module Propagation Delays						
t_{INY}	Input Data Pad to Y		4.2		4.9	ns
t_{ICKY}	Input Reg IOCLK Pad to Y		7.0		8.2	ns
t_{OCKY}	Output Reg IOCLK Pad to Y		7.0		8.2	ns
t_{ICLRY}	Input Asynchronous Clear to Y		7.0		8.2	ns
t_{OCLRY}	Output Asynchronous Clear to Y		7.0		8.2	ns
Input Module Predicted Routing Delays[2, 3]						
t_{IRD1}	FO=1 Routing Delay		1.3		1.5	ns
t_{IRD2}	FO=2 Routing Delay		1.9		2.1	ns
t_{IRD3}	FO=3 Routing Delay		2.1		2.5	ns
t_{IRD4}	FO=4 Routing Delay		2.6		2.9	ns
t_{IRD8}	FO=8 Routing Delay		4.2		4.9	ns

Notes:

1. *For dual-module macros, use $t_{PD} + t_{RD1} + t_{PDn}$, $t_{CO} + t_{RD1} + t_{PDn}$, or $t_{PD1} + t_{RD1} + t_{SUD}$, whichever is appropriate.*
2. *Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.*
3. *Optimization techniques may further reduce delays by 0 to 4 ns.*

A1460A Timing Characteristics (continued)

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

		'–1' Speed		'Std' Speed		
Parameter	**Description**	**Min.**	**Max.**	**Min.**	**Max.**	**Units**
CMOS Output Module Timing[1]						
t_{DHS}	Data to Pad, High Slew		9.2		10.8	ns
t_{DLS}	Data to Pad, Low Slew		17.3		20.3	ns
t_{ENZHS}	Enable to Pad, Z to H/L, High Slew		7.7		9.1	ns
t_{ENZLS}	Enable to Pad, Z to H/L, Low Slew		13.1		15.5	ns
t_{ENHSZ}	Enable to Pad, H/L to Z, High Slew		10.9		12.8	ns
t_{ENLSZ}	Enable to Pad, H/L to Z, Low Slew		10.9		12.8	ns
t_{CKHS}	IOCLK Pad to Pad H/L, High Slew		14.1		16.0	ns
t_{CKLS}	IOCLK Pad to Pad H/L, Low Slew		20.2		22.4	ns
d_{TLHHS}	Delta Low to High, High Slew		0.06		0.07	ns/pF
d_{TLHLS}	Delta Low to High, Low Slew		0.11		0.13	ns/pF
d_{THLHS}	Delta High to Low, High Slew		0.04		0.05	ns/pF
d_{THLLS}	Delta High to Low, Low Slew		0.05		0.06	ns/pF
Dedicated (Hard-Wired) I/O Clock Network						
t_{IOCKH}	Input Low to High (Pad to I/O Module Input)		3.5		4.1	ns
t_{IOPWH}	Minimum Pulse Width High	4.8		5.7		ns
t_{IOPWL}	Minimum Pulse Width Low	4.8		5.7		ns
t_{IOSAPW}	Minimum Asynchronous Pulse Width	3.9		4.4		ns
t_{IOCKSW}	Maximum Skew		0.9		1.0	ns
t_{IOP}	Minimum Period	9.9		11.6		ns
f_{IOMAX}	Maximum Frequency		100		85	MHz
Dedicated (Hard-Wired) Array Clock Network						
t_{HCKH}	Input Low to High (Pad to S-Module Input)		5.5		6.4	ns
t_{HCKL}	Input High to Low (Pad to S-Module Input)		5.5		6.4	ns
t_{HPWH}	Minimum Pulse Width High	4.8		5.7		ns
t_{HPWL}	Minimum Pulse Width Low	4.8		5.7		ns
t_{HCKSW}	Maximum Skew		0.9		1.0	ns
t_{HP}	Minimum Period	9.9		11.6		ns
f_{HMAX}	Maximum Frequency		100		85	MHz

Notes:

1. *Delays based on 35 pF loading.*
2. *SSO information can be found in the* Simultaneously Switching Output Limits for Actel FPGAs *application note at http://www.actel.com/appnotes.*

A1460A Timing Characteristics (continued)

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

		'–1' Speed		'Std' Speed		
Parameter	**Description**	**Min.**	**Max.**	**Min.**	**Max.**	**Units**
Routed Array Clock Networks						
t_{RCKH}	Input Low to High (FO=256)		9.0		10.5	ns
t_{RCKL}	Input High to Low (FO=256)		9.0		10.5	ns
t_{RPWH}	Min. Pulse Width High (FO=256)	6.3		7.1		ns
t_{RPWL}	Min. Pulse Width Low (FO=256)	6.3		7.1		ns
t_{RCKSW}	Maximum Skew (FO=128)		1.9		2.1	ns
t_{RP}	Minimum Period (FO=256)	12.9		14.5		ns
f_{RMAX}	Maximum Frequency (FO=256)		75		65	MHz
Clock-to-Clock Skews						
$t_{IOHCKSW}$	I/O Clock to H-Clock Skew	0.0	3.0	0.0	3.0	ns
$t_{IORCKSW}$	I/O Clock to R-Clock Skew	0.0	5.0	0.0	5.0	ns
t_{HRCKSW}	H-Clock to R-Clock Skew					
	(FO = 64)	0.0	1.0	0.0	1.0	ns
	(FO = 50% max.)	0.0	3.0	0.0	3.0	ns

A14100A Timing Characteristics (continued)

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

		'–1' Speed		'Std' Speed		
Parameter	**Description**	**Min.**	**Max.**	**Min.**	**Max.**	**Units**
Routed Array Clock Networks						
t_{RCKH}	Input Low to High (FO=256)		9.0		10.5	ns
t_{RCKL}	Input High to Low (FO=256)		9.0		10.5	ns
t_{RPWH}	Min. Pulse Width High (FO=256)	6.3		7.1		ns
t_{RPWL}	Min. Pulse Width Low (FO=256)	6.3		7.1		ns
t_{RCKSW}	Maximum Skew (FO=128)		1.9		2.1	ns
t_{RP}	Minimum Period (FO=256)	12.9		14.5		ns
f_{RMAX}	Maximum Frequency (FO=256)		75		65	MHz
Clock-to-Clock Skews						
$t_{IOHCKSW}$	I/O Clock to H-Clock Skew	0.0	3.5	0.0	3.5	ns
$t_{IORCKSW}$	I/O Clock to R-Clock Skew	0.0	5.0	0.0	5.0	ns
t_{HRCKSW}	H-Clock to R-Clock Skew (FO = 64) (FO = 50% max.)	 0.0 0.0	 1.0 3.0	 0.0 0.0	 1.0 3.0	ns

A32100DX Timing Characteristics (continued)

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

			'–1' Speed		'Std' Speed		
Parameter	**Description**		**Min.**	**Max.**	**Min.**	**Max.**	**Units**
Input Module Propagation Delays							
t_{INPY}	Input Data Pad to Y			1.9		2.6	ns
t_{INGO}	Input Latch Gate-to-Output			4.0		5.3	ns
t_{INH}	Input Latch Hold		0.0		0.0		ns
t_{INSU}	Input Latch Setup		0.7		0.9		ns
t_{ILA}	Latch Active Pulse Width		6.1		8.1		ns
Input Module Predicted Routing Delays[1]							
t_{IRD1}	FO=1 Routing Delay			2.2		2.9	ns
t_{IRD2}	FO=2 Routing Delay			2.8		3.8	ns
t_{IRD3}	FO=3 Routing Delay			3.5		4.7	ns
t_{IRD4}	FO=4 Routing Delay			3.5		4.7	ns
t_{IRD8}	FO=8 Routing Delay			5.6		7.5	ns
Global Clock Network							
t_{CKH}	Input Low to High	FO=32 FO=635		6.5 7.9		8.7 10.6	ns ns
t_{CKL}	Input High to Low	FO=32 FO=635		6.6 8.8		8.8 11.8	ns ns
t_{PWH}	Minimum Pulse Width High	FO=32 FO=635	4.1 4.6		5.5 6.1		ns ns
t_{PWL}	Minimum Pulse Width Low	FO=32 FO=635	4.1 4.6		5.5 6.1		ns ns
t_{CKSW}	Maximum Skew	FO=32 FO=635		1.8 1.8		2.4 2.4	ns ns
t_{SUEXT}	Input Latch External Setup	FO=32 FO=635	0.0 0.0		0.0 0.0		ns ns
t_{HEXT}	Input Latch External Hold	FO=32 FO=635	3.0 3.8		4.0 5.1		ns ns
t_P	Minimum Period (1/fmax)	FO=32 FO=635	7.1 7.9		9.5 10.5		ns ns
f_{HMAX}	Maximum Datapath Frequency	FO=32 FO=635		140 126		105 95	MHz MHz

Note:

1. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment. Optimization techniques may further reduce delays by 0 to 4 ns.

A32200DX Timing Characteristics (continued)

(Worst-Case Military Conditions, V_{CC} = 4.5V, T_J = 125°C)

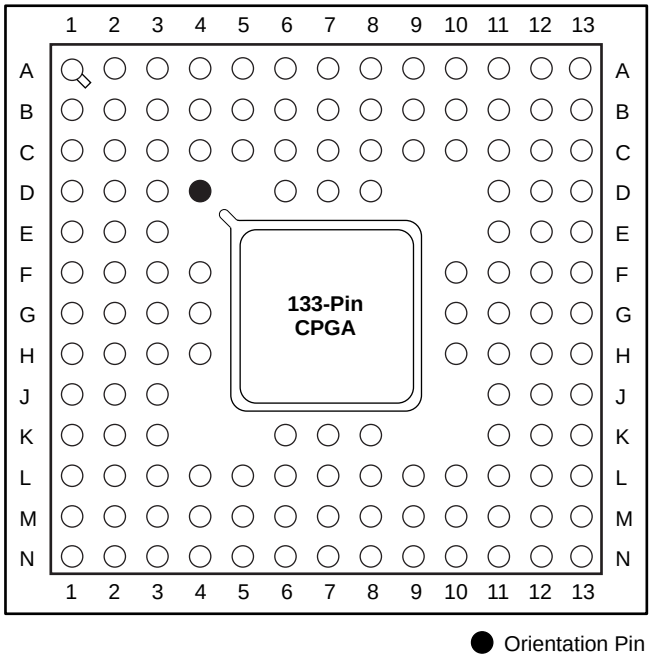
		'–1' Speed		'Std' Speed		
Parameter	**Description**	**Min.**	**Max.**	**Min.**	**Max.**	**Units**
TTL Output Module Timing[1]						
t_{DLH}	Data to Pad High		5.1		6.8	ns
t_{DHL}	Data to Pad Low		6.3		8.3	ns
t_{ENZH}	Enable Pad Z to High		6.6		8.8	ns
t_{ENZL}	Enable Pad Z to Low		7.1		9.5	ns
t_{ENHZ}	Enable Pad High to Z		11.5		15.3	ns
t_{ENLZ}	Enable Pad Low to Z		11.5		15.3	ns
t_{GLH}	G to Pad High		11.5		15.3	ns
t_{GHL}	G to Pad Low		12.3		16.5	ns
t_{LSU}	I/O Latch Output Setup	0.4		0.5		ns
t_{LH}	I/O Latch Output Hold	0.0		0.0		ns
t_{LCO}	I/O Latch Clock-Out (Pad-to-Pad) 32 I/O		11.5		15.4	ns
t_{ACO}	Array Latch Clock-Out (Pad-to-Pad) 32 I/O		16.3		21.7	ns
d_{TLH}	Capacitive Loading, Low to High		0.04		0.06	ns/pF
d_{THL}	Capacitive Loading, High to Low		0.06		0.08	ns/pF
t_{WDO}	Hard-Wired Wide Decode Output		0.05		0.07	ns
CMOS Output Module Timing[1]						
t_{DLH}	Data to Pad High		5.1		6.8	ns
t_{DHL}	Data to Pad Low		6.3		8.3	ns
t_{ENZH}	Enable Pad Z to High		6.6		8.8	ns
t_{ENZL}	Enable Pad Z to Low		7.1		9.5	ns
t_{ENHZ}	Enable Pad High to Z		11.5		15.3	ns
t_{ENLZ}	Enable Pad Low to Z		11.5		15.3	ns
t_{GLH}	G to Pad High		11.5		15.3	ns
t_{GHL}	G to Pad Low		12.3		16.5	ns
t_{LSU}	I/O Latch Setup	0.4		0.5		ns
t_{LH}	I/O Latch Hold	0.0		0.0		ns
t_{LCO}	I/O Latch Clock-Out (Pad-to-Pad) 32 I/O		13.7		18.2	ns
t_{ACO}	Array Latch Clock-Out (Pad-to-Pad) 32 I/O		19.2		25.6	ns
d_{TLH}	Capacitive Loading, Low to High		0.06		0.08	ns/pF
d_{THL}	Capacitive Loading, High to Low		0.05		0.07	ns/pF
t_{WDO}	Hard-Wired Wide Decode Output		0.05		0.07	ns

Notes:

1. *Delays based on 35 pF loading.*
2. *SSO information can be found in the* Simultaneously Switching Output Limits for Actel FPGAs *application note at http://www.actel.com/appnotes.*

Package Pin Assignments (continued)

133-Pin CPGA (Top View)



207-Pin CPGA

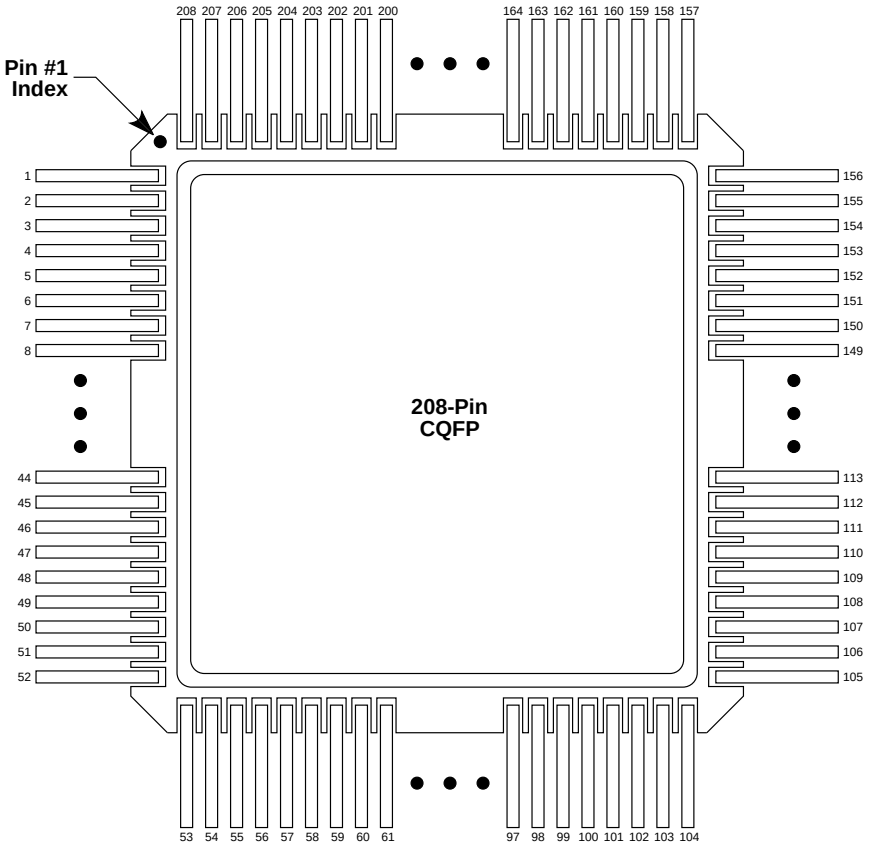
Pin Number	A1460A Function
A1	NC
A2	NC
A3	I/O
A4	I/O
A5	I/O
A6	I/O
A7	I/O
A8	I/O
A9	I/O
A10	I/O
A11	I/O
A12	I/O
A13	I/O
A14	I/O
A15	I/O
A16	NC
A17	NC
B1	NC
B2	V_{CC}
B3	I/O
B4	I/O
B5	I/O
B6	I/O
B7	I/O
B8	I/O
B9	V_{CC}
B10	I/O
B11	I/O
B12	I/O
B13	I/O
B14	I/O
B15	I/O
B16	V_{CC}
B17	NC
C1	NC
C2	NC
C3	SDI, I/O
C4	I/O
C5	I/O
C6	I/O
C7	I/O
C8	I/O
C9	I/O

Pin Number	A1460A Function
C10	I/O
C11	I/O
C12	I/O
C13	I/O
C14	I/O
C15	GND
C16	I/O
C17	I/O
D1	I/O
D2	I/O
D3	I/O
D4	GND
D5	GND
D6	I/O
D7	MODE
D8	I/O
D9	GND
D10	I/O
D11	V_{CC}
D12	I/O
D13	I/O
D14	GND
D15	I/O
D16	I/O
D17	I/O
E1	I/O
E2	I/O
E3	I/O
E4	DCLK, I/O
E14	I/O
E15	I/O
E16	I/O
E17	I/O
F1	I/O
F2	I/O
F3	I/O
F4	I/O
F14	I/O
F15	I/O
F16	I/O
F17	I/O
G1	I/O
G2	I/O

Pin Number	A1460A Function
G3	I/O
G4	I/O
G14	I/O
G15	I/O
G16	I/O
G17	I/O
H1	PRA, I/O
H2	I/O
H3	I/O
H4	I/O
H14	I/O
H15	I/O
H16	I/O
H17	I/O
J1	I/O
J2	V_{CC}
J3	CLKB, I/O
J4	GND
J14	GND
J15	HCLK, I/O
J16	V_{CC}
J17	I/O
K1	CLKA, I/O
K2	I/O
K3	I/O
K4	I/O
K14	I/O
K15	I/O
K16	PRB, I/O
K17	I/O
L1	I/O
L2	I/O
L3	I/O
L4	I/O
L14	I/O
L15	I/O
L16	I/O
L17	I/O
M1	I/O
M2	I/O
M3	I/O
M4	I/O
M14	I/O

Package Pin Assignments (continued)

208-Pin CQFP (Top View)



256-Pin CQFP

Pin Number	A14100A Function	A32200DX Function
1	GND	NC
2	SDI, I/O	GND
3	I/O	I/O
4	I/O	I/O
5	I/O	I/O
6	I/O	I/O
7	I/O	I/O
8	I/O	I/O
9	I/O	I/O
10	I/O	GND
11	MODE	I/O
12	I/O	I/O
13	I/O	I/O
14	I/O	I/O
15	I/O	I/O
16	I/O	I/O
17	I/O	I/O
18	I/O	I/O
19	I/O	I/O
20	I/O	I/O
21	I/O	I/O
22	I/O	I/O
23	I/O	I/O
24	I/O	I/O
25	I/O	I/O
26	I/O	V_{CC}
27	I/O	I/O
28	V_{CC}	I/O
29	GND	V_{CC}
30	V_{CC}	V_{CC}
31	GND	GND
32	I/O	V_{CC}
33	I/O	GND
34	I/O	TCK, I/O
35	I/O	I/O
36	I/O	GND
37	I/O	I/O
38	I/O	I/O
39	I/O	I/O
40	I/O	I/O
41	I/O	I/O
42	I/O	I/O
43	I/O	I/O
44	I/O	I/O
45	I/O	I/O
46	V_{CC}	I/O
47	I/O	I/O
48	I/O	GND
49	I/O	I/O
50	I/O	I/O
51	I/O	I/O
52	I/O	I/O
53	I/O	I/O
54	I/O	I/O
55	I/O	I/O
56	I/O	I/O
57	I/O	I/O
58	I/O	I/O
59	GND	I/O
60	I/O	V_{CC}
61	I/O	GND
62	I/O	GND
63	I/O	NC
64	I/O	NC
65	I/O	NC
66	I/O	I/O
67	I/O	SDO, I/O
68	I/O	I/O
69	I/O	I/O (WD)
70	I/O	I/O (WD)
71	I/O	I/O
72	I/O	V_{CC}
73	I/O	I/O
74	I/O	I/O
75	I/O	I/O
76	I/O	I/O (WD)
77	I/O	GND
78	I/O	I/O (WD)
79	I/O	I/O
80	I/O	QCLKB, I/O
81	I/O	I/O
82	I/O	I/O
83	I/O	I/O
84	I/O	I/O
85	I/O	I/O
86	I/O	I/O
87	I/O	I/O (WD)
88	I/O	I/O (WD)
89	I/O	I/O
90	PRB, I/O	I/O
91	GND	I/O
92	V_{CC}	I/O
93	GND	I/O
94	V_{CC}	I/O
95	I/O	V_{CC}
96	HCLK, I/O	V_{CC}
97	I/O	GND
98	I/O	GND
99	I/O	I/O
100	I/O	I/O
101	I/O	I/O
102	I/O	I/O
103	I/O	I/O
104	I/O	I/O
105	I/O	I/O (WD)
106	I/O	I/O (WD)
107	I/O	I/O
108	I/O	I/O
109	I/O	I/O (WD)
110	GND	I/O (WD)
111	I/O	I/O
112	I/O	QCLKA, I/O
113	I/O	I/O
114	I/O	GND
115	I/O	I/O
116	I/O	I/O
117	I/O	I/O
118	I/O	I/O
119	I/O	V_{CC}
120	I/O	I/O
121	I/O	I/O (WD)
122	I/O	I/O (WD)
123	I/O	I/O
124	I/O	I/O
125	I/O	TDI, I/O
126	I/O	TMS, I/O
127	IOPCL, I/O	GND
128	GND	NC
129	I/O	NC
130	I/O	NC
131	I/O	GND
132	I/O	I/O

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